Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/536,866	NIIKURA ET AL.	
Examiner	Art Unit	
Wilson Tsui	2178	

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	522	4/12/2007	WT
707	200	4/12/2007	wr
707	104.1	4/12/2007	WT
			•

· INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		•			
		***			
	l				

	H NOTES ARCH STRATEGY	)
-	DATE	EXMR
East Search USPAT, USPGPUB See Notes	4/12/2007	WT
*		
•		
٠.		